

Search Notes

Application/Control No.

10/738,397

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

JIN ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	705	1/26/2007	BT
438	724	1/26/2007	BT
438	744	1/26/2007	BT

INTERFERENCE SEARCHED

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438	705	1/26/2007	BT
438	724	1/26/2007	BT
438	744	1/26/2007	BT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search using databases in EAST	1/26/2007	BT